

# STD150NH02L-1

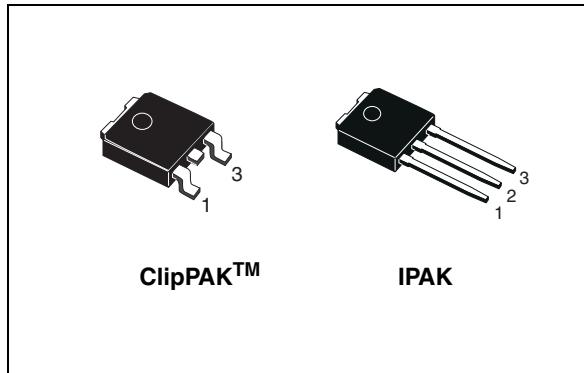
## STD150NH02L

N-channel 24V - 0.003Ω - 150A - ClipPAK™ - IPAK  
STripFET™ III Power MOSFET

### General features

Type	V <sub>DSSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
STD150NH02L	24V	<0.0035Ω	150A
STD150NH02L-1	24V	<0.0035Ω	150A

- R<sub>DS(on)</sub> \* Qg industry's benchmark
- Conduction losses reduced
- Switching losses reduced
- Low threshold device



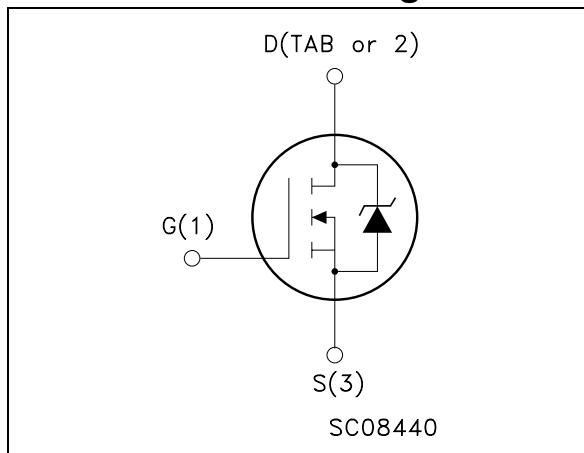
### Description

The STD150NH02L utilizes the latest advanced design rules of ST's proprietary STripFET™ technology. This novel 0.6µ process utilizes also unique metallization techniques that couple to a "bondless" assembly technique result in outstanding performance with standard DPAK outline. It is therefore ideal in high performance DC-DC converter applications where efficiency is to be achieved at very high out currents.

### Applications

- Switching application

### Internal schematic diagram



### Order codes

Part number	Marking	Package	Packaging
STD150NH02LT4	D150NH02L	ClipPAK™	Tape & reel
STD150NH02L-1	D150NH02L	IPAK	Tube

# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{\text{spike}}^{(1)}$	Drain-source voltage rating	30	V
$V_{\text{DS}}$	Drain-source voltage ( $V_{\text{GS}} = 0$ )	24	V
$V_{\text{DGR}}$	Drain-gate voltage ( $R_{\text{GS}} = 20\text{K}\Omega$ )	24	V
$V_{\text{GS}}$	Drain-source voltage	$\pm 20$	V
$I_{\text{D}}$	Drain current (continuous) at $T_{\text{C}} = 25^{\circ}\text{C}$	150	A
$I_{\text{D}}$	Drain current (continuous) at $T_{\text{C}}=100^{\circ}\text{C}$	107	A
$I_{\text{DM}}^{(2)}$	Drain current (pulsed)	600	A
$P_{\text{TOT}}$	Total dissipation at $T_{\text{C}} = 25^{\circ}\text{C}$	125	W
	Derating factor	0.83	$\text{W}/^{\circ}\text{C}$
$E_{\text{AS}}^{(3)}$	Single pulse avalanche energy	500	mJ
$T_{\text{stg}}$	Storage temperature	$-55 \text{ to } 175$	$^{\circ}\text{C}$
$T_{\text{J}}$	Max. operating junction temperature		

1. Garanteed when external  $R_{\text{g}} = 4.7 \Omega$  and  $t_f < t_{f\text{max}}$ .

2. Pulse width limited by safe operating area

3. Starting  $T_{\text{J}} = 25^{\circ}\text{C}$ ,  $I_{\text{D}} = 75\text{A}$ ,  $V_{\text{DD}} = 10\text{V}$

**Table 2. Thermal data**

Symbol	Parameter	Value	Unit
$R_{\text{thJC}}$	Thermal resistance junction-case Max	1.2	$^{\circ}\text{C/W}$
$R_{\text{thJA}}$	Thermal resistance junction-ambient Max	100	$^{\circ}\text{C/W}$
$T_{\text{I}}$	Maximum lead temperature for soldering purpose	275	$^{\circ}\text{C}$

## 2 Electrical characteristics

( $T_{CASE}=25^{\circ}\text{C}$  unless otherwise specified)

**Table 3. On<sup>(1)</sup> /off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 25\text{mA}$ , $V_{GS} = 0$	24			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 20\text{V}$ $V_{DS} = 20\text{V}$ , $T_C = 125^{\circ}\text{C}$		1 10	$\mu\text{A}$ $\mu\text{A}$	
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 20\text{V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\mu\text{A}$	1	1.8		V
$R_{DS(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10\text{V}$ , $I_D = 75\text{A}$ $V_{GS} = 5\text{V}$ , $I_D = 37.5\text{A}$		0.003 0.004	0.0035 0.0065	$\Omega$ $\Omega$

1. Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

**Table 4. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$g_{fs}^{(1)}$	Forward transconductance	$V_{DS} = 10\text{ V}$ , $I_D = 75\text{A}$		60		S
$C_{iss}$ $C_{oss}$ $C_{rss}$	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 15\text{V}$ , $f = 1\text{ MHz}$ , $V_{GS} = 0$		4450 1126 141		pF pF pF
$Q_g$ $Q_{gs}$ $Q_{gd}$	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 16\text{V}$ , $I_D = 150\text{A}$ $V_{GS} = 10\text{V}$		69 13 9	93	nC nC nC
$Q_{oss}^{(2)}$	Output charge	$V_{DS} = 16\text{V}$ , $V_{GS} = 0\text{V}$		27		nC
$Q_{gls}^{(3)}$	Third-quadrant gate charge	$V_{DS} < 0\text{V}$ , $V_{GS} = 10\text{V}$		64		nC
$R_G$	Gate input resistance	$f = 1\text{MHz}$ gate DC Bias = 0 Test signal level = 20mV Open drain		1.6		$\Omega$

1. Pulsed: pulse duration=300 $\mu\text{s}$ , duty cycle 1.5%

2.  $Q_{oss} = C_{oss} * \Delta V_{in}$ ,  $C_{oss} = C_{gd} + C_{ds}$ . See Appendix A

3. Gate charge for synchronous operation

**Table 5. Switching times**

<b>Symbol</b>	<b>Parameter</b>	<b>Test conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 10V, I_D = 75A,$ $R_G = 4.7\Omega, V_{GS} = 10V$		14	54	ns
$t_r$	Rise time			224		
$t_{d(off)}$	Turn-off delay time			69		
$t_f$	Fall time			40		

**Table 6. Source drain diode**

<b>Symbol</b>	<b>Parameter</b>	<b>Test conditions</b>	<b>Min</b>	<b>Typ.</b>	<b>Max</b>	<b>Unit</b>
$I_{SD}$	Source-drain current				150	A
$I_{SDM}$	Source-drain current (pulsed)				600	A
$V_{SD}^{(1)}$	Forward on voltage	$I_{SD} = 75A, V_{GS} = 0$			1.15	V
$t_{rr}$ $Q_{rr}$ $I_{RRM}$	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 150A,$ $di/dt = 100A/\mu s,$ $V_{DD} = 15V, T_J = 150^\circ C$		47 58 2.5		ns $\mu C$ A

1. Pulsed: pulse duration=300 $\mu s$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

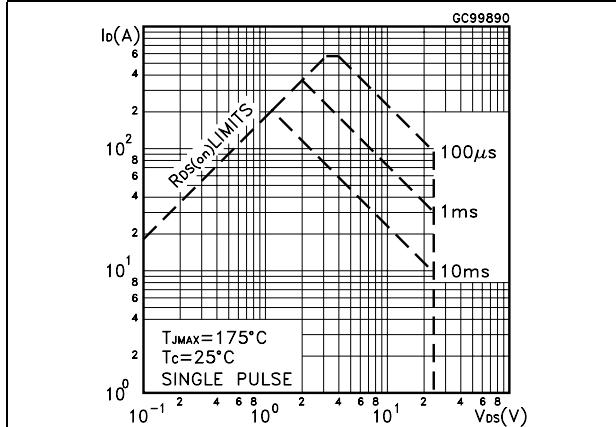


Figure 2. Thermal impedance

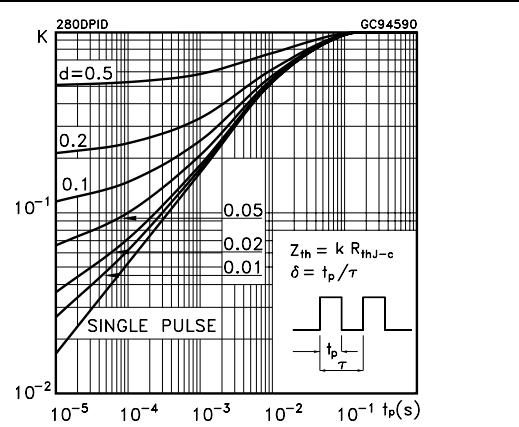


Figure 3. Output characteristics

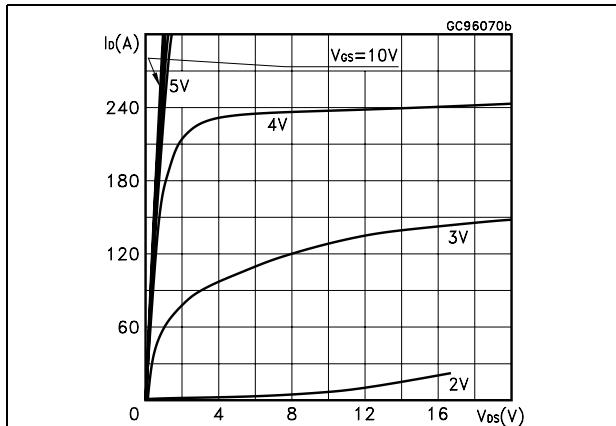


Figure 4. Transfer characteristics

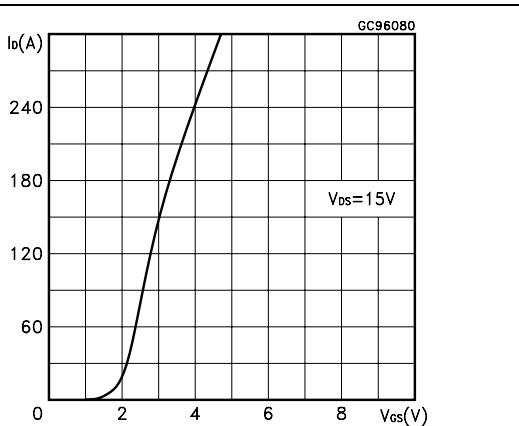


Figure 5. Transconductance

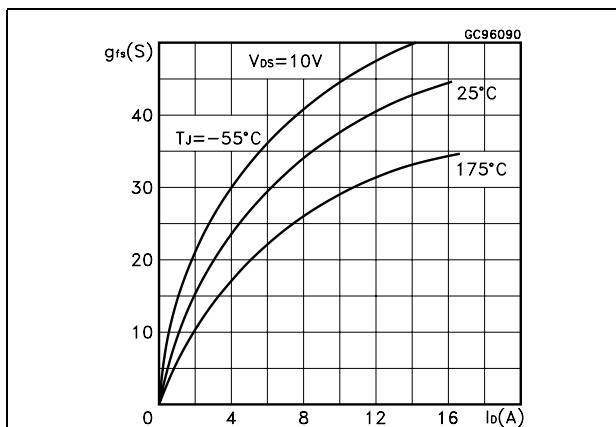


Figure 6. Static drain-source on resistance

